

**Search Notes**

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Examiner

VAN T. PHAM

Applicant(s)/Patent under  
Reexamination

FEEHAN ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
369		10/12/2006	VP
347		10/12/2006	VP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB)  369, 430,101,264,451,347 (text search only see search history printout).	10/12/2006	VP